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	APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.			
09/911,995		07/24/2001	Sei-Hyung Ryu	5308-156	5240			
	20792 7	590 10/06/2004	EXAMINER					
		MYERS BIGEL SIBLEY & SAJOVEC PO BOX 37428			MUNSON, GENE M			
	RALEIGH, NO	=		ART UNIT	PAPER NUMBER			
				2811				

DATE MAILED: 10/06/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

 □ Notice of Reference(s) Cited, PTO-892 □ Notice of Draftsperson's Patent Drawing Review, PTO-948 		Other				
III Notice of Defetelicers Cited. P10-032		.5 01 111011	i wont Applicati	5,5 i i 0 - 102		
	•		mal Patent Applicati	on PTΩ_150		
★ Information Disclosure Statement(s), PTO-1449, Paper No(s) ★ Information Disclosure Statement(s) ★ Information Disclosure Statement(s)	s). 9/02/04 🖂 I	nterview Sum	mary, PTO-413			
Attachment(s)						
☐ Copies of the certified copies of the priority documents in this national stage application from the International *Certified copies not received:	have been received Bureau (PCT Rule 17.2	2(a))		_ •		
☐ Certified copies of the priority documents have been received in Application No						
☐ Certified copies of the priority documents have been re	ceived.					
 □ Acknowledgement is made of a claim for foreign priority ur □ All □ Some* □ None of the: 	ider 35 U.S.C. § 119 (a	a)—(d).				
Priority under 35 U.S.C. § 119 (a)–(d)		n				
☐ The oath or declaration is objected to by the Examiner.						
☐ The specification is objected to by the Examiner.						
☐ The drawing(s) filed on is/are object	ed to by the Examiner					
☐ The proposed drawing correction, filed on	* *		ed.			
Application Papers		require				
□ Claim(s)			oject to restriction or	election		
☐ Claim(s)		•				
M Claim(s) 1, 2, 4-6, 8-14, 16-20, 23-25, 27-31,						
☑ Claim(s) 15, 31, 22, 26, 32, 38, 39						
Of the above claim(s)						
Claim(s) 1, 3, 4-6, 8-41, 83, 84, 87-89		is/are r	pending in the applic	cation.		
accordance with the practice under <i>Ex parte Quayle</i> , 1935. Disposition of Claims	C.D. 1 1; 453 O.G. 213	3.				
☐ Since this application is in condition for allowance except			to the merits is clo	sed in		
☐ This action is FINAL.						
☑ Responsive to communication(s) filed on	, 2 September	2004		· ·		
Status						
 Extensions of time may be available under the provisions of 37 CFR 1 from the mailing date of this communication. If the period for reply specified above is less than thirty (30) days, a re If NO period for reply is specified above, such period shall, by default, Failure to reply within the set or extended period for reply will, by state Any reply received by the Office later than three months after the mail term adjustment. See 37 CFR 1.704(b). 	oly within the statutory mi expire SIX (6) MONTHS fi tte, cause the application	nimum of thirty (rom the mailing o to become ABAI	30) days will be conside date of this communica NDONED (35 U.S.C. § 1	ered timely. tion. 33).		
OF THIS COMMUNICATION.		·				
A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO	EXPIRE THREE	F MONTHS	S) FROM THE MAII	ING DATE		
Period for Reply						
-The MAILING DATE of this communication appears	on the cover sheet b	eneath the co	orrespondence add	tress—		
	G. MUNS	PN	2811			
Office Action Summary	09/9/1, 995 Examiner		Group Art Unit			
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Serial Number: 09/911,995 Page 2

Art Unit: 2811

Examination is continued under 37 CFR 1.114.

Claims 4, 25, 27-31, and 33-37 are rejected under 35 U.S.C. 112, first and second paragraphs. Claim 4 appears misdescriptive, because "n-type shorting channels" 26' in Figure 7 do extend "beyond a periphery of the p-type silicon carbide regions" 20 as n-type "epitaxial" layer 27. Claim 25, that appears directed to the embodiment of Figure 7, is inconsistent with independent claim 12, which does not appear to read on Figure 7. In response, applicants should attempt to read claim 12 on Figure 7.

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 1, 2, 4, 6, 10-12, 17-19, 23-25, 33-36, 40, 41, 83, 84 and 89 are rejected under 35 U.S.C. 103 as unpatentable over Okuno et al '822 and the Chung el al article (4/01), of record, considered together. The Chung el al article is considered as prior art under 35 U.S.C. 102(f) as requested by applicants in the paper filed 3 July 2003. Okuno et al (Figures 1, 4, 7C) show "drift" layer 2 (claims 4, 25), or for independent claims 1, 12 & 83, layer 2 plus the inherent subportion of layer 5 on layer 2; "p-type" regions 3a, 3b; "n-type" regions 4a, 4b; "n-type shorting channels" inherent subportions of layer 5 in regions 3a, 3b. The "n-type shorting channels" read on inherent subportions of layer 5 in regions 3a, 3b, and the "drift" layer reads on layer 2 plus the inherent subportion of layer

Serial Number: 09/911,995 Page 3

Art Unit: 2811

5 on layer 2. For film 7, it would have been obvious to use "nitrided oxide" as suggested by Chung el

al (pages 177-8; Figures 1, 2), in order to achieve higher mobility. From Chung el al (page 177,

Figure 1), it would have been obvious to decrease "interface state density" comparable to that in

Chung el al (claims 10, 17, 33).

Claims 8, 9, 13, 14, 16, 27-31 and 87 are rejected under 35 U.S.C. 103 as unpatentable, the

evidence being Okuno et al '822 and the Chung el al article (4/01), as in the above rejection, further

considered with Okuno et al '700 of record. It would have been obvious to use a thickness of layer 5

equal to or less than 0.3 µm, as suggested by Okuno et al '700 (columns 3-4), and a dopant

concentration of from less than 1×10^{15} to 1×10^{17} cm⁻³, as suggested by Okuno et al '700 (column 2)

and Okuno et al '822 (column 2), in order to achieve depletion of layer 5.

Claims 5, 20, 37 and 88 are rejected under 35 U.S.C. 103 as unpatentable, the evidence being

Okuno et al '822 and the Chung el al article (4/01), as in the above rejection, further considered with

Fujii et al '231 of record. It would have been obvious to dope polysilicon gate electrode 8 as in

Okuno et al '822 with a p-type dopant, as in Fujii et al (column 7), in order to achieve a low

resistance for a contact.

Claims 15, 21, 22, 26, 32, 38 and 39 are allowed over the art of record.

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9/30/04